Notice of References Cited Application/Control No. 10/523,313 Applicant(s)/Patent Under Reexamination STEIGER, ECKARD Examiner John A. Tweel, Jr. Applicant(s)/Patent Under Reexamination STEIGER, ECKARD Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,440,487	08-1995	Althoff et al.	701/43
*	В	US-6,704,628	03-2004	Fennel et al.	701/29
*	С	US-7,162,312	01-2007	Gross et al.	700/79
	D	US-			
	E ·	US-			
	F	US-			
	G	US-			
	Н	US-			
	T	US-			
	J	US-			
	К	US-		·	
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	, Name	Classification
	N					
	0					·
	Р		*			
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	×	

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.